Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/785,612	QIU ET AL.
Examiner	Art Unit
Erich A. Leeser	1624

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
514/267 w	544/251, vith search e printout	9/11/2007	EL

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
reviewed STN structure search	9/11/2007	EL
updated PALM inventor search	9/11/2007	EL
reviewed 544/251, 514/267 with search terms, see printout	9/11/2007	EL